

vPolyTan™ Solid Tantalum Surface Mount Chip Capacitors, Molded Case, High Performance Polymer Type



PERFORMANCE / ELECTRICAL CHARACTERISTICS

Operating Temperature: -55 °C to +105 °C
(above 85 °C, voltage derating is required)

Capacitance Range: 3.3 µF to 470 µF

Capacitance Tolerance: ± 20 %

Voltage Rating: 2.5 V_{DC} to 35 V_{DC}

FEATURES

- Ultra-low ESR
- Molded case available in 7 case codes
- Terminations:
cases J, P: 100 % tin
case A: 100 % tin or Ni/Pd/Au
cases T, B, V, D: Ni/Pd/Au
- Compatible with “high volume” automatic pick and place equipment
- Moisture sensitivity level 3
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



RoHS
COMPLIANT
HALOGEN
FREE
GREEN
(5-2008)

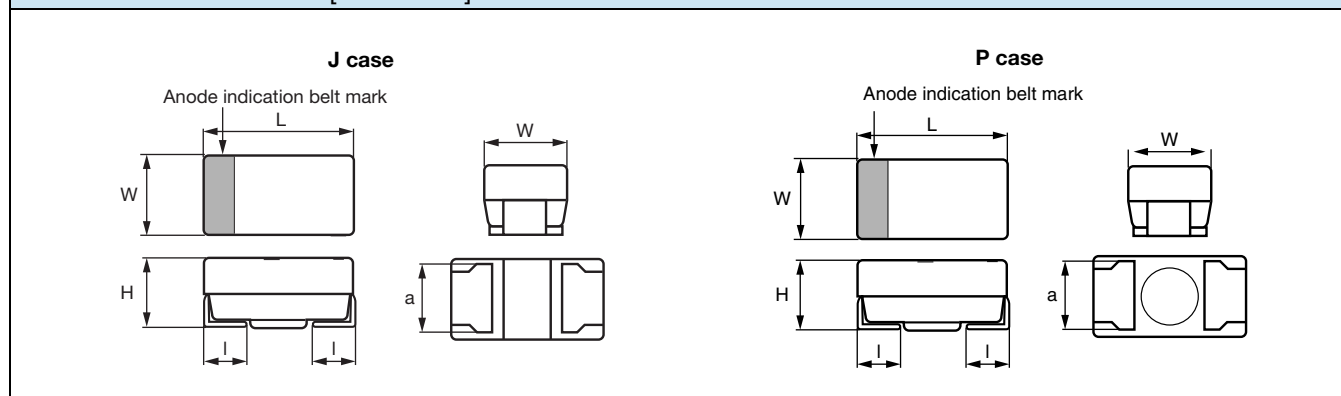
APPLICATIONS

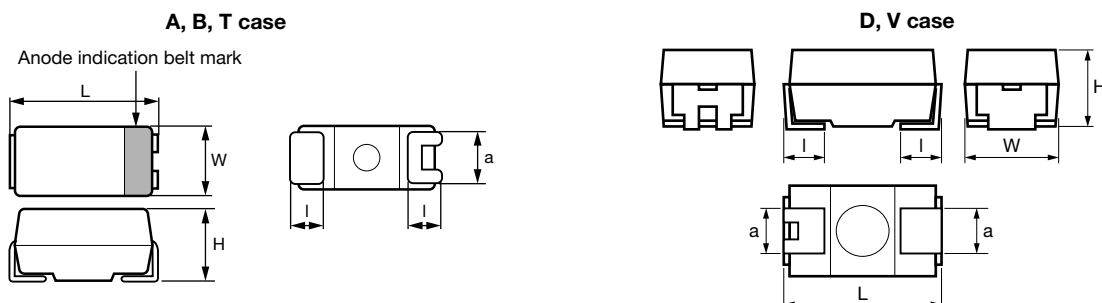
- Decoupling, smoothing, filtering
- Bulk energy storage in wireless cards
- Infrastructure equipment
- Storage and networking
- Computer motherboards
- Smartphones and tablets

ORDERING INFORMATION

T55 TYPE	B CASE CODE	156 CAPACITANCE	M CAPACITANCE TOLERANCE	6R3 DC VOLTAGE RATING AT +85 °C	C TERMINATION / PACKAGING	0500 ESR
	See Ratings and Case Codes table	This is expressed in picofarads. The first two digits are the significant figures. The third is the number of zeros to follow.	M = ± 20 %	This is expressed in volts. To complete the three-digit block, zeros precede the voltage rating. A decimal point is indicated by an “R” (6R3 = 6.3 V)	C = lead (Pb)-free solderable coating, 7" reel	Maximum 100 kHz ESR in mΩ

DIMENSIONS in inches [millimeters]



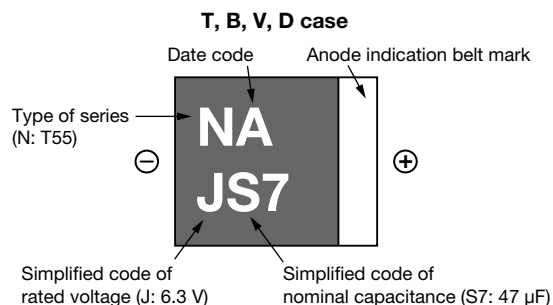
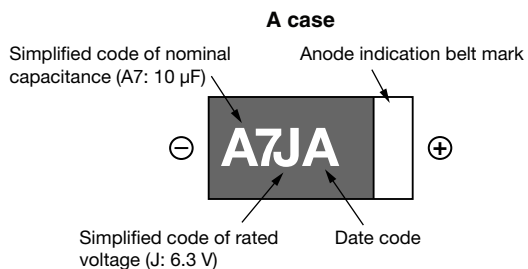
DIMENSIONS in inches [millimeters]


CASE CODE	EIA SIZE	L	W	H	I	a
J	1608-09	0.063 ± 0.004 [1.6 ± 0.1]	0.031 ± 0.004 [0.8 ± 0.1]	0.031 ± 0.004 [0.8 ± 0.1]	0.012 ± 0.006 [0.3 ± 0.15]	0.024 ± 0.004 [0.6 ± 0.1]
P	2012-12	0.080 ± 0.008 [2.0 ± 0.2]	0.049 ± 0.008 [1.25 ± 0.2]	0.047 max. [1.2 max.]	0.020 ± 0.008 [0.5 ± 0.2]	0.035 ± 0.004 [0.9 ± 0.1]
A	3216-18	0.126 ± 0.008 [3.2 ± 0.2]	0.063 ± 0.008 [1.6 ± 0.2]	0.063 ± 0.008 [1.6 ± 0.2]	0.028 ± 0.012 [0.7 ± 0.3]	0.047 ± 0.008 [1.2 ± 0.2]
T	3528-12	0.138 ± 0.008 [3.5 ± 0.2]	0.110 ± 0.008 [2.8 ± 0.2]	0.047 max. [1.2 max.]	0.030 ± 0.012 [0.8 ± 0.3]	0.087 ± 0.008 [2.2 ± 0.2]
B	3528-21	0.138 ± 0.008 [3.5 ± 0.2]	0.110 ± 0.008 [2.8 ± 0.2]	0.075 ± 0.008 [1.9 ± 0.2]	0.030 ± 0.012 [0.8 ± 0.3]	0.087 ± 0.008 [2.2 ± 0.2]
V	7343-20	0.287 ± 0.008 [7.3 ± 0.2]	0.169 ± 0.012 [4.3 ± 0.3]	0.079 max. [2.0 max.]	0.051 ± 0.012 [1.3 ± 0.3]	0.094 ± 0.008 [2.4 ± 0.2]
D	7343-30	0.287 ± 0.008 [7.3 ± 0.2]	0.169 ± 0.012 [4.3 ± 0.3]	0.110 ± 0.008 [2.8 ± 0.2]	0.051 ± 0.012 [1.3 ± 0.3]	0.094 ± 0.008 [2.4 ± 0.2]

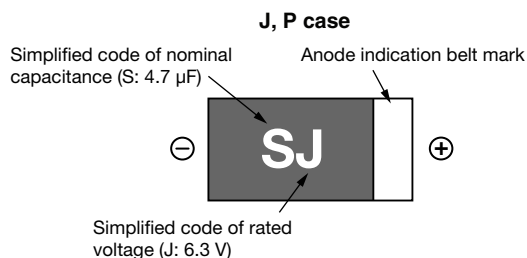
RATINGS AND CASE CODES

μF	2.5 V	4.0 V	6.3 V	10 V	16 V	20 V	25 V	35 V
3.3			J / P	J / P				
4.7			J / P / A	P / A				
6.8			P / A	A				B
10		J / P / A	P / A	A			B	
15		P / A	A	A		B		
22		A / B	A / T	A / T / B	B			
33		A / B	A / T / B	A / T / B				
47		A / T / B	A / T / B	B				
68		A / T / B	T / B	V ⁽¹⁾				
100		T / B	A / T / B	D				
150		B	B					
220	B	B	B / V ⁽¹⁾	D ⁽¹⁾				
330	B		V ⁽¹⁾ / D					
470	B	D ⁽¹⁾						

Note
⁽¹⁾ In development.

MARKING


VOLTAGE CODE		CAPACITANCE CODE	
V	CODE	CAP, µF	CODE
2.5	e	3.3	N6
4	G	4.7	S6
6.3	J	6.8	W6
10	A	10	A7
16	C	15	E7
20	D	22	J7
25	E	33	N7
35	V	47	S7
		68	W7
		100	A8
		150	E8
		220	J8
		330	N8
		470	S8



RATED VOLTAGE	CAPACITANCE	MARKING
4	10	AG
4	15	EG
6.3	3.3	NJ
6.3	4.7	SJ
6.3	6.8	WJ
6.3	10	AJ
10	3.3	NA
10	4.7	SA

DATE CODE

YEAR	MONTH											
	1	2	3	4	5	6	7	8	9	10	11	12
2013	A	B	C	D	E	F	G	H	J	K	L	M
2014	N	P	Q	R	S	T	U	V	W	X	Y	Z
2015	a	b	c	d	e	f	g	h	j	k	l	m
2016	n	p	q	r	s	t	u	v	w	x	y	z



STANDARD RATINGS

CAPACITANCE (μ F)	CASE CODE	PART NUMBER	MAX. DCL AT 25 °C (μ A)	MAX. DF AT 25 °C 120 Hz (%)	MAX. ESR AT + 25 °C 100 kHz (m Ω)	MAX. RIPPLE, 100 kHz I _{RMS} (A)
2.5 V _{DC} AT +85 °C, 2 V _{DC} AT +105 °C						
220	B	T55B227M2R5C0070	55.0	10	70	1.36
220	B	T55B227M2R5C0035	55.0	10	35	1.93
220	B	T55B227M2R5C0030	55.0	10	30	2.08
330	B	T55B337M2R5C0070	82.5	10	70	1.36
330	B	T55B337M2R5C0045	82.5	10	45	1.70
330	B	T55B337M2R5C0035	82.5	10	35	1.93
330	B	T55B337M2R5C0025	82.5	10	25	2.28
470	B	T55B477M2R5C0025	117.5	10	25	2.28
4 V _{DC} AT +85 °C, 3.2 V _{DC} AT +105 °C						
10	J	T55J106M004C0500	10.0	10	500	0.32
10	P	T55P106M004C0500	5.0	10	500	0.36
10	P	T55P106M004C0200	5.0	10	200	0.56
10	A	T55A106M004C0500	4.0	10	500	0.48
10	A	T55A106M004C0200	4.0	10	200	0.76
15	P	T55P156M004C0500	10.0	10	500	0.36
15	P	T55P156M004C0200	10.0	10	200	0.56
15	A	T55A156M004C0500	6.0	10	500	0.48
15	A	T55A156M004C0200	6.0	10	200	0.76
22	A	T55A226M004C0500	8.8	10	500	0.48
22	A	T55A226M004C0200	8.8	10	200	0.76
22	B	T55B226M004C0200	8.8	10	200	0.81
33	A	T55A336M004C0500	13.2	10	500	0.48
33	A	T55A336M004C0200	13.2	10	200	0.76
33	B	T55B336M004C0200	13.2	10	200	0.81
47	A	T55A476M004C0500	18.8	10	500	0.48
47	A	T55A476M004C0200	18.8	10	200	0.76
47	T	T55T476M004C0200	18.8	10	200	0.72
47	T	T55T476M004C0080	18.8	10	80	1.15
47	T	T55T476M004C0070	18.8	10	70	1.22
47	B	T55B476M004C0150	18.8	10	150	0.93
47	B	T55B476M004C0070	18.8	10	70	1.36
68	A	T55A686M004C0500	27.2	10	500	0.48
68	A	T55A686M004C0200	27.2	10	200	0.76
68	T	T55T686M004C0200	27.2	10	200	0.72
68	T	T55T686M004C0080	27.2	10	80	1.15
68	T	T55T686M004C0070	27.2	10	70	1.22
68	B	T55B686M004C0150	27.2	10	150	0.93
68	B	T55B686M004C0070	27.2	10	70	1.36
100	T	T55T107M004C0150	40.0	10	150	0.84
100	T	T55T107M004C0070	40.0	10	70	1.22
100	B	T55B107M004C0070	40.0	10	70	1.36
100	B	T55B107M004C0045	40.0	10	45	1.70
100	B	T55B107M004C0040	40.0	10	40	1.80
150	B	T55B157M004C0070	60.0	10	70	1.36
150	B	T55B157M004C0035	60.0	10	35	1.93
220	B	T55B227M004C0070	88.0	10	70	1.36
220	B	T55B227M004C0045	88.0	10	45	1.70
220	B	T55B227M004C0035	88.0	10	35	1.93
470	D ⁽¹⁾	T55D477M004C0025	188.0	10	25	3.00

Notes

- Termination code "C": cases J, P: 100 % tin, case A: 100 % tin or Ni/Pd/Au, cases T, B, V, D: Ni/Pd/Au.

⁽¹⁾ In development.



STANDARD RATINGS						
CAPACITANCE (μ F)	CASE CODE	PART NUMBER	MAX. DCL AT 25 °C (μ A)	MAX. DF AT 25 °C 120 Hz (%)	MAX. ESR AT + 25 °C 100 kHz (m Ω)	MAX. RIPPLE, 100 kHz I _{RMS} (A)
6.3 V _{DC} AT +85 °C, 5 V _{DC} AT +105 °C						
3.3	J	T55J335M6R3C0500	10.0	10	500	0.32
3.3	P	T55P335M6R3C0500	5.0	10	500	0.36
4.7	J	T55J475M6R3C0500	10.0	10	500	0.32
4.7	P	T55P475M6R3C0500	5.0	10	500	0.36
4.7	A	T55A475M6R3C0500	3.0	10	500	0.48
6.8	P	T55P685M6R3C0500	5.0	10	500	0.36
6.8	A	T55A685M6R3C0500	4.2	10	500	0.48
10	P	T55P106M6R3C0500	10.0	10	500	0.36
10	P	T55P106M6R3C0200	10.0	10	200	0.56
10	A	T55A106M6R3C0500	6.3	10	500	0.48
10	A	T55A106M6R3C0200	6.3	10	200	0.76
15	A	T55A156M6R3C0500	9.4	10	500	0.48
15	A	T55A156M6R3C0200	9.4	10	200	0.76
22	A	T55A226M6R3C0500	13.8	10	500	0.48
22	A	T55A226M6R3C0200	13.8	10	200	0.76
22	T	T55T226M6R3C0150	13.8	10	150	0.84
33	A	T55A336M6R3C0500	20.7	10	500	0.48
33	A	T55A336M6R3C0200	20.7	10	200	0.76
33	T	T55T336M6R3C0200	20.7	10	200	0.72
33	T	T55T336M6R3C0150	20.7	10	150	0.84
33	T	T55T336M6R3C0070	20.7	10	70	1.22
33	B	T55B336M6R3C0200	20.7	10	200	0.81
33	B	T55B336M6R3C0070	20.7	10	70	1.36
33	B	T55B336M6R3C0040	20.7	10	40	1.80
47	A	T55A476M6R3C0500	29.6	10	500	0.48
47	A	T55A476M6R3C0200	29.6	10	200	0.76
47	A	T55A476M6R3C0150	29.6	10	150	0.88
47	A	T55A476M6R3C0070	29.6	10	70	1.28
47	T	T55T476M6R3C0200	29.6	10	200	0.72
47	T	T55T476M6R3C0080	29.6	10	80	1.15
47	T	T55T476M6R3C0070	29.6	10	70	1.22
47	B	T55B476M6R3C0150	29.6	10	150	0.93
47	B	T55B476M6R3C0070	29.6	10	70	1.36
68	T	T55T686M6R3C0200	42.8	10	200	0.72
68	T	T55T686M6R3C0070	42.8	10	70	1.22
68	B	T55B686M6R3C0150	42.8	10	150	0.93
68	B	T55B686M6R3C0070	42.8	10	70	1.36
100	A	T55A107M6R3C0200	63.0	10	200	0.76
100	A	T55A107M6R3C0150	63.0	10	150	0.88
100	A	T55A107M6R3C0070	63.0	10	70	1.28
100	T	T55T107M6R3C0070	63.0	10	70	1.22
100	B	T55B107M6R3C0100	63.0	10	100	1.14
100	B	T55B107M6R3C0070	63.0	10	70	1.36
100	B	T55B107M6R3C0045	63.0	10	45	1.70
100	B	T55B107M6R3C0040	63.0	10	40	1.80
100	B	T55B107M6R3C0035	63.0	10	35	1.93
150	B	T55B157M6R3C0100	94.5	10	100	1.14
150	B	T55B157M6R3C0070	94.5	10	70	1.36
150	B	T55B157M6R3C0045	94.5	10	45	1.70
150	B	T55B157M6R3C0040	94.5	10	40	1.80
150	B	T55B157M6R3C0035	94.5	10	35	1.93
220	B	T55B227M6R3C0070	138.6	10	70	1.36
220	B	T55B227M6R3C0035	138.6	10	35	1.93
220	V ⁽¹⁾	T55V227M6R3C0025	138.6	10	25	2.73
330	V ⁽¹⁾	T55V337M6R3C0025	207.9	10	25	2.73
330	D	T55D337M6R3C0040	207.9	10	40	2.37
330	D ⁽¹⁾	T55D337M6R3C0025	207.9	10	25	3.00

Notes

- Termination code "C": cases J, P: 100 % tin, case A: 100 % tin or Ni/Pd/Au, cases T, B, V, D: Ni/Pd/Au.

⁽¹⁾ In development.



STANDARD RATINGS						
CAPACITANCE (μ F)	CASE CODE	PART NUMBER	MAX. DCL AT 25 °C (μ A)	MAX. DF AT 25 °C 120 Hz (%)	MAX. ESR AT + 25 °C 100 kHz (m Ω)	MAX. RIPPLE, 100 kHz I _{RMS} (A)
10 V _{DC} AT +85 °C, 8 V _{DC} AT +105 °C						
3.3	J	T55J335M010C0500	10.0	10	500	0.32
3.3	P	T55P335M010C0500	5.0	10	500	0.36
4.7	P	T55P475M010C0500	10.0	10	500	0.36
4.7	P	T55P475M010C0200	10.0	10	200	0.56
4.7	A	T55A475M010C0500	4.7	10	500	0.48
4.7	A	T55A475M010C0200	4.7	10	200	0.76
6.8	A	T55A685M010C0500	6.8	10	500	0.48
6.8	A	T55A685M010C0200	6.8	10	200	0.76
10	A	T55A106M010C0500	10.0	10	500	0.48
10	A	T55A106M010C0200	10.0	10	200	0.76
15	A	T55A156M010C0500	15.0	10	500	0.48
15	A	T55A156M010C0200	15.0	10	200	0.76
22	A	T55A226M010C0500	22.0	10	500	0.48
22	A	T55A226M010C0200	22.0	10	200	0.76
22	T	T55T226M010C0200	22.0	10	200	0.72
22	T	T55T226M010C0150	22.0	10	150	0.84
22	T	T55T226M010C0070	22.0	10	70	1.22
22	B	T55B226M010C0300	22.0	10	300	0.66
22	B	T55B226M010C0200	22.0	10	200	0.81
22	B	T55B226M010C0070	22.0	10	70	1.36
33	A	T55A336M010C0500	33.0	10	500	0.48
33	A	T55A336M010C0150	33.0	10	150	0.88
33	A	T55A336M010C0070	33.0	10	70	1.28
33	A	T55A336M010C0200	33.0	10	200	0.76
33	T	T55T336M010C0200	33.0	10	200	0.72
33	T	T55T336M010C0150	33.0	10	150	0.84
33	T	T55T336M010C0070	33.0	10	70	1.22
33	B	T55B336M010C0200	33.0	10	200	0.81
33	B	T55B336M010C0070	33.0	10	70	1.36
47	B	T55B476M010C0150	47.0	10	150	0.93
47	B	T55B476M010C0070	47.0	10	70	1.36
68	V ⁽¹⁾	T55V686M010C0060	68.0	10	60	1.76
100	D	T55D107M010C0055	100.0	10	55	2.02
220	D ⁽¹⁾	T55D227M010C0025	220.0	10	25	3.00
16 V _{DC} AT +85 °C, 12.8 V _{DC} AT +105 °C						
22	B	T55B226M016C0070	35.2	10	70	1.36
20 V _{DC} AT +85 °C, 16 V _{DC} AT +105 °C						
15	B	T55B156M020C0070	30.0	10	70	1.36
25 V _{DC} AT +85 °C, 20 V _{DC} AT +105 °C						
10	B	T55B106M025C0100	25.0	10	100	1.14
35 V _{DC} AT +85 °C, 28 V _{DC} AT +105 °C						
6.8	B	T55B685M035C0200	23.8	10	200	0.81

Notes

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- ⁽¹⁾ In development.

**RECOMMENDED VOLTAGE DERATING GUIDELINES** (for temperature below +85 °C)

CAPACITOR VOLTAGE RATING	OPERATING VOLTAGE
2.5	2.0
4.0	3.2
6.3	5.0
10	8.0
16	12.8
20	16
25	20
35	28

POWER DISSIPATION

CASE CODE	MAXIMUM PERMISSIBLE POWER DISSIPATION (W) AT $\leq +45$ °C IN FREE AIR
J	0.050
P	0.064
A	0.115
T	0.105
B	0.130
V	0.187
D	0.225

STANDARD PACKAGING QUANTITY

CASE CODE	UNITS PER 7" REEL
J	4000
P	3000
A	2000
T	3000
B	2000
V	500
D	500



PERFORMANCE CHARACTERISTICS					
ITEM	CONDITION	POST TEST PERFORMANCE			
Temperature characteristics	Measure the specified characteristics in each stage		Specified initial value	-55 °C	+105 °C
		Capacitance change	-	-20 % to 0 %	0 % to 30 %
		Dissipation factor shown in Standard Ratings table or less	10	14	-
		Leakage current	Refer to Standard Ratings table	-	Not more than 1 CV or 30 μA which is greater
Solder heat resistance	Reflow board surface peak temperature: less than 260 °C Time: 5 s max.	Capacitance change	Within ± 20 % of initial value		
		Dissipation factor	Initial specified value or less		
		Leakage current	Shall not exceed 300 % of initial specified value		
Moisture resistance no load	Leave at 40 °C and 90 % to 95 % RH for 500 h	Capacitance change	Within +40 % -20 % of initial value		
		Dissipation factor	Initial specified value or less		
		Leakage current	Shall not exceed 300 % of initial specified value		
High temperature load	85 °C. The rated voltage is applied through a protective resistor of 3 Ω for 1000 h	Capacitance change	Within ± 20 % of initial value		
		Dissipation factor	Initial specified value or less		
		Leakage current	Shall not exceed 300 % of initial specified value		
Thermal shock	Leave at -55 °C, normal temperature, 105 °C, and normal temperature for 30 min., 15 min. 30 min., and 15 min. Repeat this operation 5 times running.	Capacitance change	Within ± 20 % of initial value or less		
		Dissipation factor	Initial specified value or less		
		Leakage current	Shall not exceed 300 % of initial specified value		
Failure rate	85 °C. The rated voltage is applied through a protective resistor of 1 Ω/V.	1 % / 1000 h			

Note

- Test conditions per JIS C5101-1



Guide for Tantalum Solid Electrolyte Chip Capacitors with Polymer Cathode

INTRODUCTION

Tantalum electrolytic capacitors are the preferred choice in applications where volumetric efficiency, stable electrical parameters, high reliability, and long service life are primary considerations. The stability and resistance to elevated temperatures of the tantalum/tantalum oxide/manganese dioxide system make solid tantalum capacitors an appropriate choice for today's surface mount assembly technology.

Vishay Sprague has been a pioneer and leader in this field, producing a large variety of tantalum capacitor types for consumer, industrial, automotive, military, and aerospace electronic applications.

Tantalum is not found in its pure state. Rather, it is commonly found in a number of oxide minerals, often in combination with Columbium ore. This combination is known as "tantalite" when its contents are more than one-half tantalum. Important sources of tantalite include Australia, Brazil, Canada, China, and several African countries. Synthetic tantalite concentrates produced from tin slags in Thailand, Malaysia, and Brazil are also a significant raw material for tantalum production.

Electronic applications, and particularly capacitors, consume the largest share of world tantalum production. Other important applications for tantalum include cutting tools (tantalum carbide), high temperature super alloys, chemical processing equipment, medical implants, and military ordnance.

Vishay Sprague is a major user of tantalum materials in the form of powder and wire for capacitor elements and rod and sheet for high temperature vacuum processing.

THE BASICS OF TANTALUM CAPACITORS

Most metals form crystalline oxides which are non-protecting, such as rust on iron or black oxide on copper. A few metals form dense, stable, tightly adhering, electrically insulating oxides. These are the so-called "valve" metals and include titanium, zirconium, niobium, tantalum, hafnium, and aluminum. Only a few of these permit the accurate control of oxide thickness by electrochemical means. Of these, the most valuable for the electronics industry are aluminum and tantalum.

Capacitors are basic to all kinds of electrical equipment, from radios and television sets to missile controls and automobile ignitions. Their function is to store an electrical charge for later use.

Capacitors consist of two conducting surfaces, usually metal plates, whose function is to conduct electricity. They are separated by an insulating material or dielectric. The dielectric used in all tantalum electrolytic capacitors is tantalum pentoxide.

Tantalum pentoxide compound possesses high-dielectric strength and a high-dielectric constant. As capacitors are being manufactured, a film of tantalum pentoxide is applied to their electrodes by means of an electrolytic process. The film is applied in various thicknesses and at various voltages and although transparent to begin with, it takes on different colors as light refracts through it. This coloring occurs on the tantalum electrodes of all types of tantalum capacitors.

Rating for rating, tantalum capacitors tend to have as much as three times better capacitance/volume efficiency than aluminum electrolytic capacitors. An approximation of the capacitance/volume efficiency of other types of capacitors may be inferred from the following table, which shows the dielectric constant ranges of the various materials used in each type. Note that tantalum pentoxide has a dielectric constant of 26, some three times greater than that of aluminum oxide. This, in addition to the fact that extremely thin films can be deposited during the electrolytic process mentioned earlier, makes the tantalum capacitor extremely efficient with respect to the number of microfarads available per unit volume. The capacitance of any capacitor is determined by the surface area of the two conducting plates, the distance between the plates, and the dielectric constant of the insulating material between the plates.

COMPARISON OF CAPACITOR DIELECTRIC CONSTANTS

DIELECTRIC	ϵ DIELECTRIC CONSTANT
Air or vacuum	1.0
Paper	2.0 to 6.0
Plastic	2.1 to 6.0
Mineral oil	2.2 to 2.3
Silicone oil	2.7 to 2.8
Quartz	3.8 to 4.4
Glass	4.8 to 8.0
Porcelain	5.1 to 5.9
Mica	5.4 to 8.7
Aluminum oxide	8.4
Tantalum pentoxide	26
Ceramic	12 to 400K

In the tantalum electrolytic capacitor, the distance between the plates is very small since it is only the thickness of the tantalum pentoxide film. As the dielectric constant of the tantalum pentoxide is high, the capacitance of a tantalum capacitor is high if the area of the plates is large:

$$C = \frac{\epsilon A}{t}$$

where

C = capacitance

ϵ = dielectric constant

A = surface area of the dielectric

t = thickness of the dielectric

Tantalum capacitors contain either liquid or solid electrolytes. In solid electrolyte capacitors, a dry material (manganese dioxide) forms the cathode plate. A tantalum lead is embedded in or welded to the pellet, which is in turn connected to a termination or lead wire. The drawings show the construction details of the surface mount types of tantalum capacitors shown in this catalog.

SOLID ELECTROLYTE TANTALUM CAPACITORS

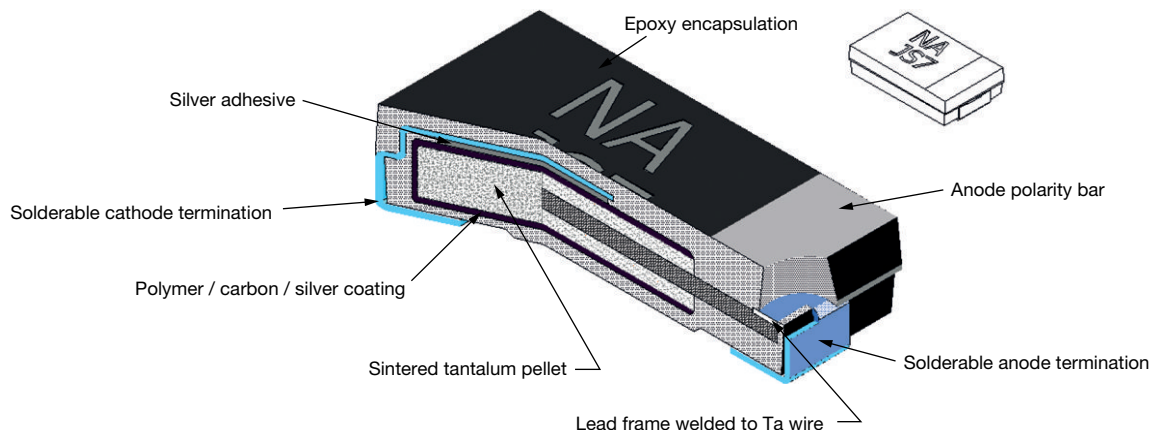
Solid electrolyte polymer capacitors utilizes high performance polymer as cathode system, which is formed on the tantalum pentoxide dielectric layer.

The pellet is then coated with graphite, followed by a layer of metallic silver, which provides a conductive surface between the pellet and the outer termination (leadframe or other).


Molded chip polymer tantalum capacitor encases the element in plastic resins, such as epoxy materials. After assembly, the capacitors are tested and inspected to assure long life and reliability. It offers excellent reliability and high stability for consumer and commercial electronics.

Surface mount designs of T55 solid tantalum polymer capacitors use lead frames.

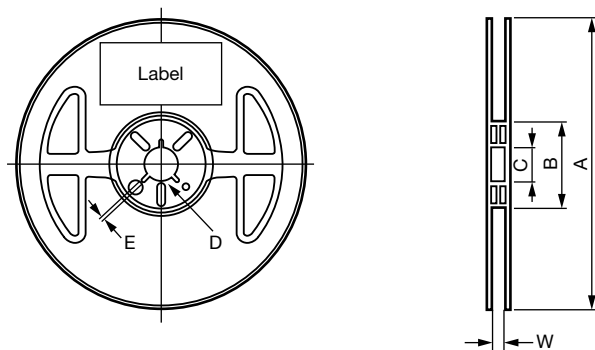
TANTALUM CAPACITOR WITH POLYMER CATHODE TYPE T55



SOLID TANTALUM CAPACITORS - MOLDED CASE

SERIES	T55
PRODUCT IMAGE	
TYPE	VPolyTan™, molded case, high performance polymer
TEMPERATURE RANGE	Operating temperature: -55 °C to +105 °C (above 85 °C, voltage derating is required)
CASE SIZES	J, P, A, T, B, V, D
CAPACITANCE RANGE	3.3 µF to 470 µF
VOLTAGE RANGE	2.5 V to 35 V
CAPACITANCE TOLERANCE	± 20 %
DISSIPATION FACTOR	10 % maximum
ESR	25 mΩ to 500 mΩ
TERMINATION	Cases J, P: 100 % tin Case A: 100 % tin or Ni/Pd/Au Cases T, B, V, D: Ni/Pd/Au

REEL PACKAGING in millimeters

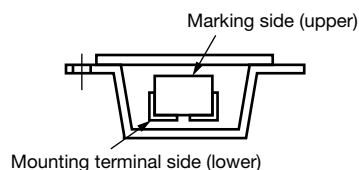
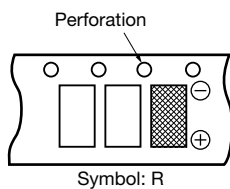
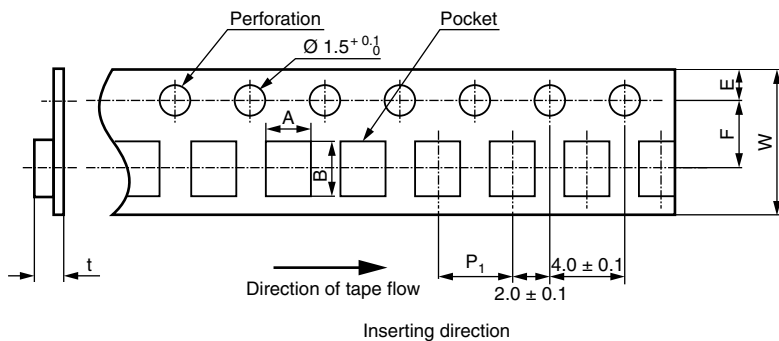


TAPE WIDTH	8	12
A + 0 / - 3	Ø 180	←
B + 1 / 0	Ø 60	←
C ± 0.2	Ø 13	←
D ± 0.5	Ø 21	←
E ± 0.5	2.0	←
W ± 0.3	9.0	13.0

Note

- A reel diameter of 330 mm is also applicable.

TAPE SIZE in millimeters



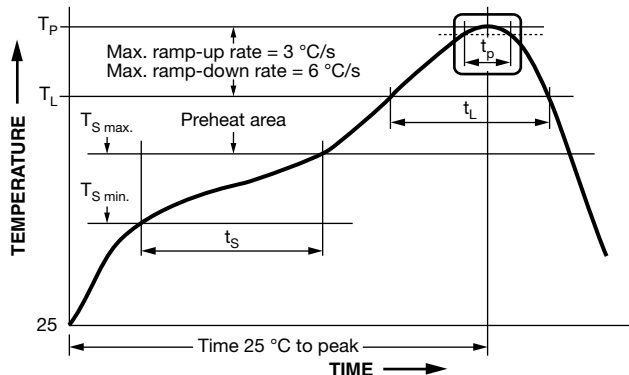
CASE CODE	A ± 0.2	B ± 0.2	W ± 0.3	F ± 0.1	E ± 0.1	P ₁ ± 0.1	t _{max.}
J	1.0	1.8	8.0	3.5	1.75	4.0	1.3
P	1.4	2.2	8.0	3.5	1.75	4.0	1.6
A	1.9	3.5	8.0	3.5	1.75	4.0	2.5
T	3.1	3.8	8.0	3.5	1.75	4.0	1.7
B	3.1	3.8	8.0	3.5	1.75	4.0	2.5
V	4.8	7.7	12.0	5.5	1.75	8.0	2.6
D	4.8	7.7	12.0	5.5	1.75	8.0	3.4

PACKING AND STORAGE

T55 capacitors meet moisture sensitivity level rating (MSL) of 3 as specified in IPC/JEDEC® J-STD-020D.1 and are dry packaged in moisture barrier bags (MBB) per J-STD-033. Level 3 specifies a floor life (out of bag) of 168 hours at 30 °C maximum and 60 % relative humidity (RH). Unused capacitors should be re-sealed in the MMB with fresh desiccant. A moisture strip (humidity indicator card) is included in the bag to assure dryness. To remove excess moisture, capacitors can be dried at 40 °C (standard “dry box” conditions).

For detailed recommendations please refer to J-STD-033.

RECOMMENDED REFLOW PROFILES

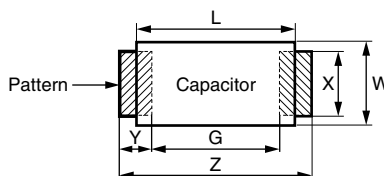


PROFILE FEATURE	LEAD (Pb)-FREE ASSEMBLY
Preheat/soak	
Temperature min. ($T_{S\ min.}$)	150 °C
Temperature max. ($T_{S\ max.}$)	200 °C
Time (t_S) from ($T_{S\ min.}$ to $T_{S\ max.}$)	60 s to 120 s
Ramp-up rate (T_L to T_P)	3 °C/s max.
Liquidus temperature (T_L)	217 °C
Time (t_L) maintained above T_L	60 s to 150 s
Peak package body temperature (T_P) max.	260 °C
Time (t_P) within 5 °C of the peak max. temperature	5 s max.
Ramp-down rate (T_P to T_L)	6 °C/s max.
Time from 25 °C to peak temperature	8 min max.

Note

- T55 capacitors are process sensitive. PSL classification to JEDEC J-STD-075: R4G.

PAD DIMENSIONS in millimeters



CASE / DIMENSIONS	CAPACITOR SIZE		PAD DIMENSIONS			
	L	W	G (max.)	Z (min.)	X (min.)	Y (Ref.)
J	1.6	0.8	0.7	2.5	1.0	0.9
P	2.0	1.25	0.5	2.6	1.2	1.05
A	3.2	1.6	1.1	3.8	1.5	1.35
T / B	3.5	2.8	1.4	4.1	2.7	1.35
V / D	7.3	4.3	4.1	8.2	2.9	2.05

GUIDE TO APPLICATION

1. **AC Ripple Current:** the maximum allowable ripple current shall be determined from the formula:

$$I_{RMS} = \sqrt{\frac{P}{R_{ESR}}}$$

where,

P = power dissipation in W at +25 °C as given in the tables in the product datasheets. (power dissipation)

R_{ESR} = the capacitor equivalent series resistance at the specified frequency.

2. **AC Ripple Voltage:** the maximum allowable ripple voltage shall be determined from the formula:

$$V_{RMS} = Z \sqrt{\frac{P}{R_{ESR}}}$$

or, from the formula:

$$V_{RMS} = I_{RMS} \times Z$$

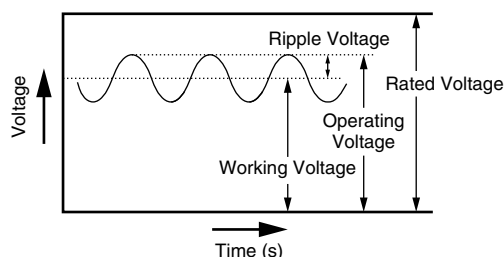
where,

P = power dissipation in W at +25 °C as given in the tables in the product datasheets. (power dissipation)

R_{ESR} = The capacitor equivalent series resistance at the specified frequency.

Z = The capacitor impedance at the specified frequency.

- 2.1 The tantalum capacitors must be used in such a condition that the sum of the working voltage and ripple voltage peak values does not exceed the rated voltage as shown in figure below.



3. **Temperature Derating:** power dissipation is affected by the heat sinking capability of the mounting surface. If these capacitors are to be operated at temperatures above +45 °C, the permissible ripple current (or voltage) shall be calculated using the derating coefficient as shown in the table below:

MAXIMUM RIPPLE CURRENT TEMPERATURE DERATING FACTOR	
≤ 45 °C	1.0
55 °C	0.8
85 °C	0.6
105 °C	0.4

4. **Reverse Voltage:** these capacitors are capable of withstanding peak voltages in the reverse direction equal to 10 % of the DC rating at +25 °C, 5 % of the DC rating at +25 °C, 5 % of the DC rating at +85 °C, and 1 % of the DC rating at +105 °C.

5. **Mounting Precautions:**

- 5.1 **Limit Pressure on Capacitor Installation with Mouter:** pressure must not exceed 4.9 N with a tool end diameter of 1.5 mm when applied to the capacitors using an absorber, centering tweezers, or similar (maximum permitted pressurization time: 5 s). An excessively low absorber setting position would result in not only the application of undue force to the capacitors but capacitor and other component scattering, circuit board wiring breakage, and / or cracking as well, particularly when the capacitors are mounted together with other chips having a height of 1 mm or less.

- 5.2 **Flux Selection**

- 5.2.1 Select a flux that contains a minimum of chlorine and amine.

- 5.2.2 After flux use, the chlorine and amine in the flux remain must be removed.

- 5.3 **Cleaning After Mounting:** the following solvents are usable when cleaning the capacitors after mounting. Never use a highly active solvent.

- Halogen organic solvent (HCFC225, etc.)
- Alcoholic solvent (IPA, ethanol, etc.)
- Petroleum solvent, alkali saponifying agent, water, etc.

Circuit board cleaning must be conducted at a temperature of not higher than 50 °C and for an immersion time of not longer than 30 minutes. When an ultrasonic cleaning method is used, cleaning must be conducted at a frequency of 48 kHz or lower, at an vibrator output of 0.02 W/cm³, at a temperature of not higher than 40 °C, and for a time of 5 minutes or shorter.

Notes

- Care must be exercised in cleaning process so that the mounted capacitor will not come into contact with any cleaned object or the like or will not get rubbed by a stiff brush or similar. If such precautions are not taken particularly when the ultrasonic cleaning method is employed, terminal breakage may occur.
- When performing ultrasonic cleaning under conditions other than stated above, conduct adequate advance checkout.



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